

TEST REPORT

Applicant: Shenzhen Zhixu Technology Co., LTD
Address: 1101, Building A, Guoren Building, Keji Zhongshan Road, Gaoxin Park, Nanshan District, Shenzhen City, China.
Equipment Type: PCB Onboard Antenna
Model Name: ZXD1888
Brand Name: Kashimura
Test Standard: ANSI/IEEE Std 149-1979
Test Date: Sep. 23, 2022
Date of Issue: Sep. 27, 2022

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.



Tested by: Mai Jintian

Checked by: Tolan Tu

Approved by: Wei Yanquan
(Chief Engineer)

Mai Jintian

Tolan Tu

Wei Yanquan

| Revision History | | |
|-------------------------|----------------------|----------------------|
| Version | Issue Date | Revisions |
| <u>Rev. 01</u> | <u>Sep. 27, 2022</u> | <u>Initial Issue</u> |

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1 GENERAL INFORMATION

1.1 Test Laboratory

| | |
|--------------|--|
| Name | Shenzhen BALUN Technology Co., Ltd. |
| Address | Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China |
| Phone Number | +86 755 6685 0100 |

1.2 Test Location

| | |
|----------|---|
| Name | Shenzhen BALUN Technology Co., Ltd. |
| Location | <input checked="" type="checkbox"/> Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China |
| | <input type="checkbox"/> 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China |

2 PRODUCT INFORMATION

2.1 Applicant Information

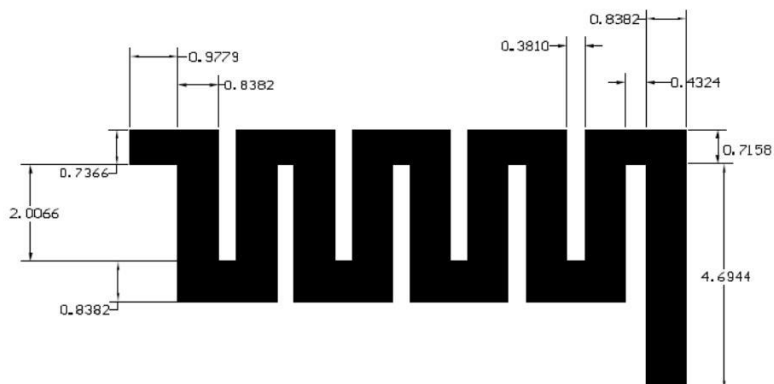
| | |
|-----------|---|
| Applicant | Shenzhen Zhixu Technology Co., LTD |
| Address | 1101, Building A, Guoren Building, Keji Zhongsan Road, Gaoxin Park, Nanshan District, Shenzhen City, China. |

2.2 Manufacturer Information

| | |
|--------------|---|
| Manufacturer | Shenzhen Zhixu Technology Co., LTD |
| Address | 1101, Building A, Guoren Building, Keji Zhongsan Road, Gaoxin Park, Nanshan District, Shenzhen City, China. |

2.3 General Description for Equipment under Test (EUT)

| | |
|-----------------------|---------------------|
| EUT Name | PCB Onboard Antenna |
| Model Name Under Test | ZXD1888 |
| Antenna Type | PCB Antenna |
| Dimensions | 11.8*5.4 mm |



2.4 Ancillary Equipment

Note: Not applicable.

2.5 Technical Information

| | |
|------------------|---|
| Test Frequencies | 2400MHz, 2410MHz, 2420MHz, 2430MHz, 2440MHz, 2450MHz, 2460MHz, 2470MHz, 2480MHz, 2490MHz, 2500MHz |
|------------------|---|

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

| No. | Identity | Document Title |
|-----|------------------------|--|
| 1 | ANSI/IEEE Std 149-1979 | IEEE Standard Test Procedures for Antennas |

3.2 Test Verdict

| Report Section | Description | Remark |
|----------------|---------------------|--------|
| ANNEX A.1 | Gain and Efficiency | -- |
| ANNEX B | Radiation Pattern | -- |

3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

| Item | Uncertainty |
|------|---------------------|
| Gain | $\pm 1.92\text{dB}$ |

4 GENERAL TEST CONFIGURATIONS

4.1 Test Condition

| Environment Parameter | Selected Values During Tests | | | |
|---|------------------------------|-----------------|---------|-----------------------|
| | Ambient Pressure(KPa) | Temperature(°C) | Voltage | Relative Humidity (%) |
| Normal Temperature, Normal Voltage (NTNV) | 101 | 25 | N/A | 50 |

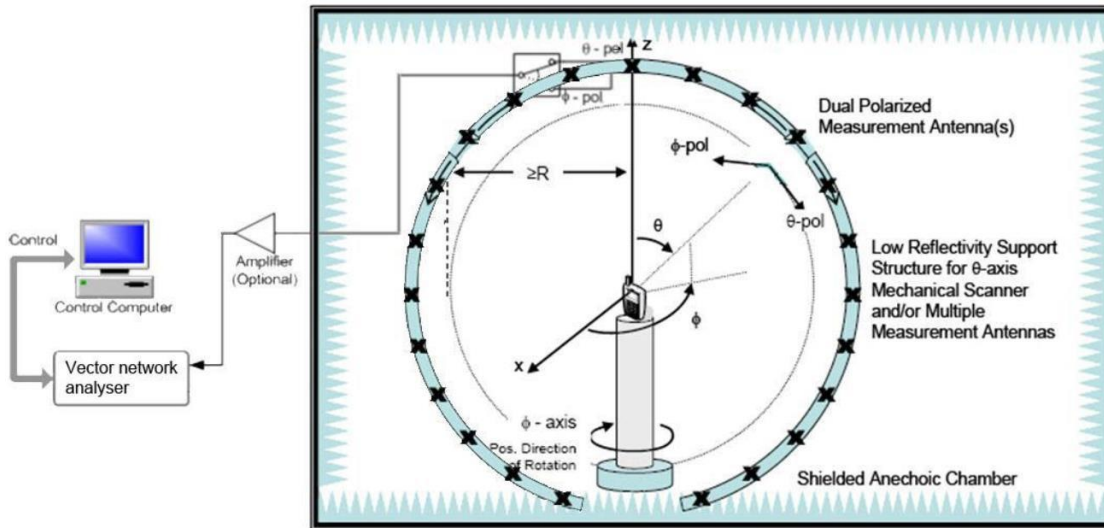
4.2 Test Equipment List

| Description | Manufacturer | Model | Serial No. | Cal. Date | Cal. Due |
|---|--------------|--------|--------------|------------|------------|
| SG24 Multi-probe Antenna Measurement System | SATIMO | SG24-L | 1101855-0001 | 2021.11.12 | 2024.11.11 |
| Vector Network Analyzer | Agilent | E5071B | MY42404001 | 2022.04.02 | 2023.04.01 |
| Description | Manufacturer | Name | | Version | |
| Test Software | MVG | SPM | | V 1.8 | |

Add: Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China

4.3 Test Setup

4.3.1 Antenna gain, efficiency and radiation pattern test setup



ANNEX A TEST RESULTS

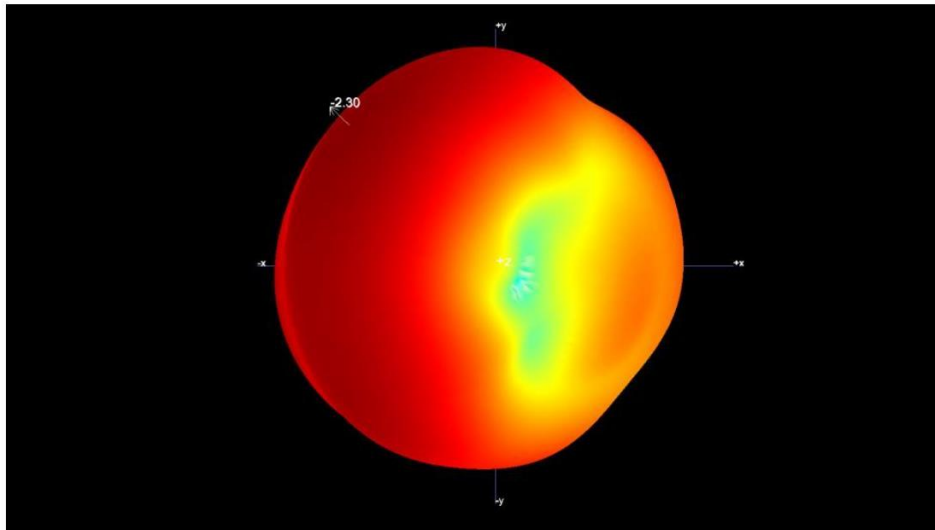
A.1 Gain and Efficiency

| Frequency | Gain (dBi) | Efficiency (%) |
|-----------|--------------|----------------|
| 2400MHz | -2.30 | 20 |
| 2410MHz | -2.40 | 20 |
| 2420MHz | -2.49 | 21 |
| 2430MHz | -2.57 | 20 |
| 2440MHz | -2.69 | 19 |
| 2450MHz | -2.86 | 19 |
| 2460MHz | -3.06 | 19 |
| 2470MHz | -3.23 | 19 |
| 2480MHz | -3.29 | 18 |
| 2490MHz | -3.22 | 18 |
| 2500MHz | -3.58 | 18 |

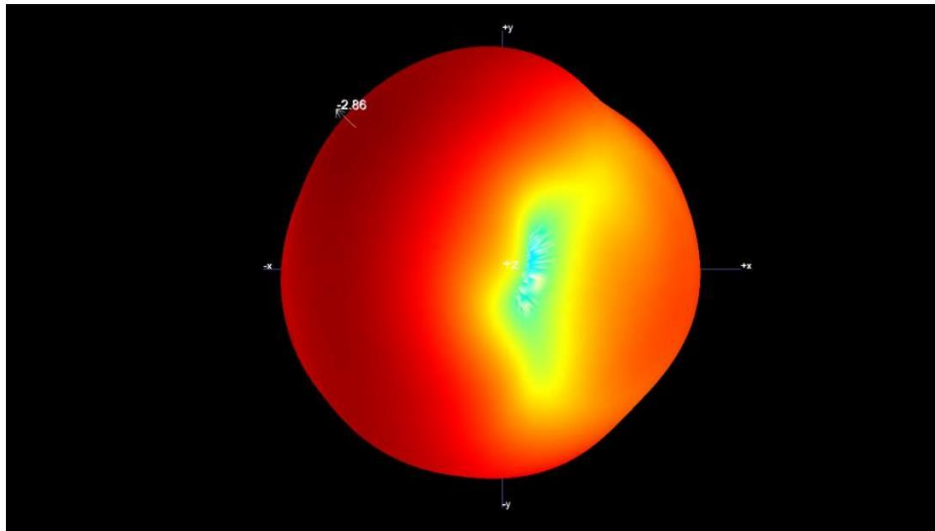
ANNEX B RADIATION PATTERN

B.1 3D Pattern

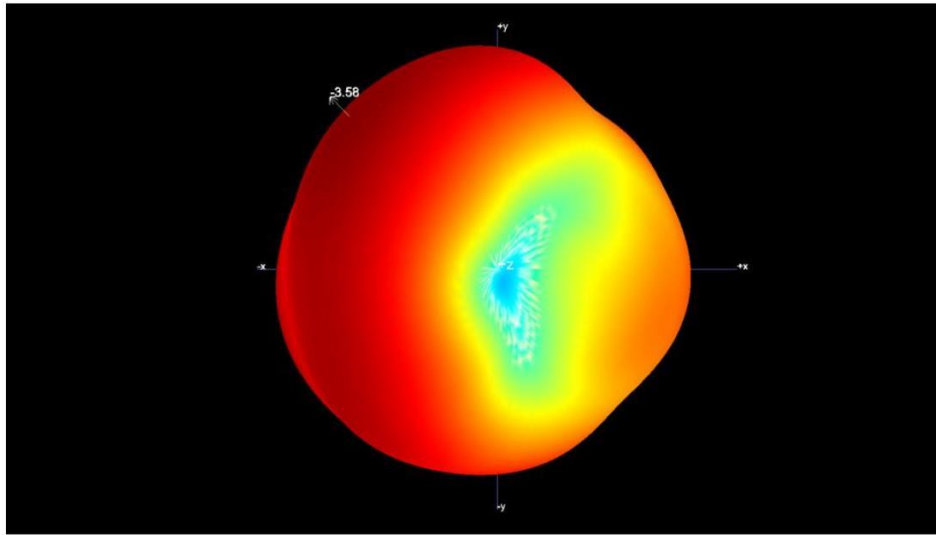
B1.1 3D Pattern for 2400MHz



B1.2 3D Pattern for 2450MHz

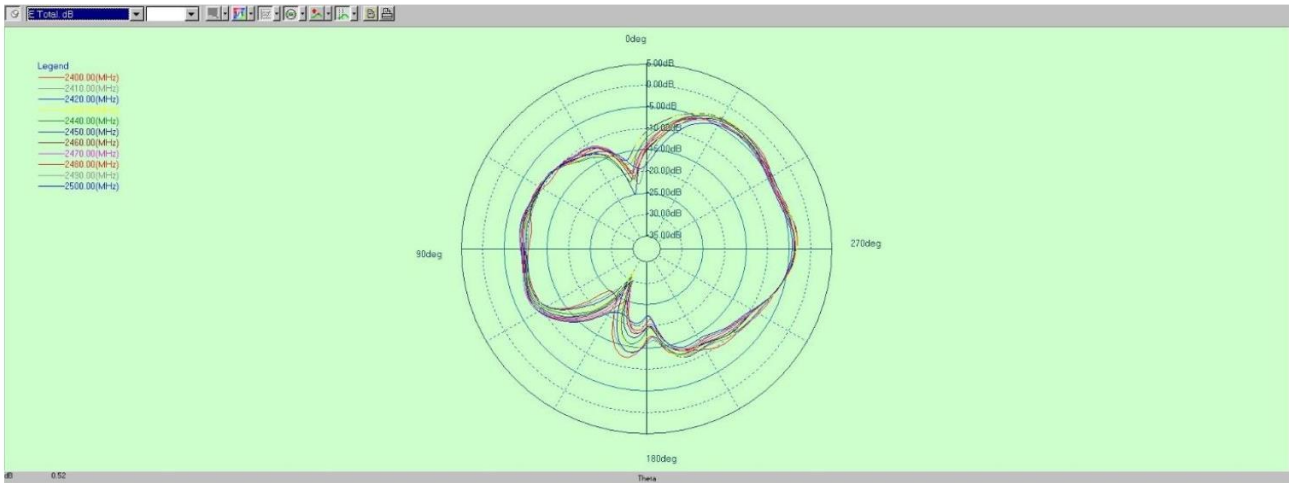


B1.3 3D Pattern for 2500MHz

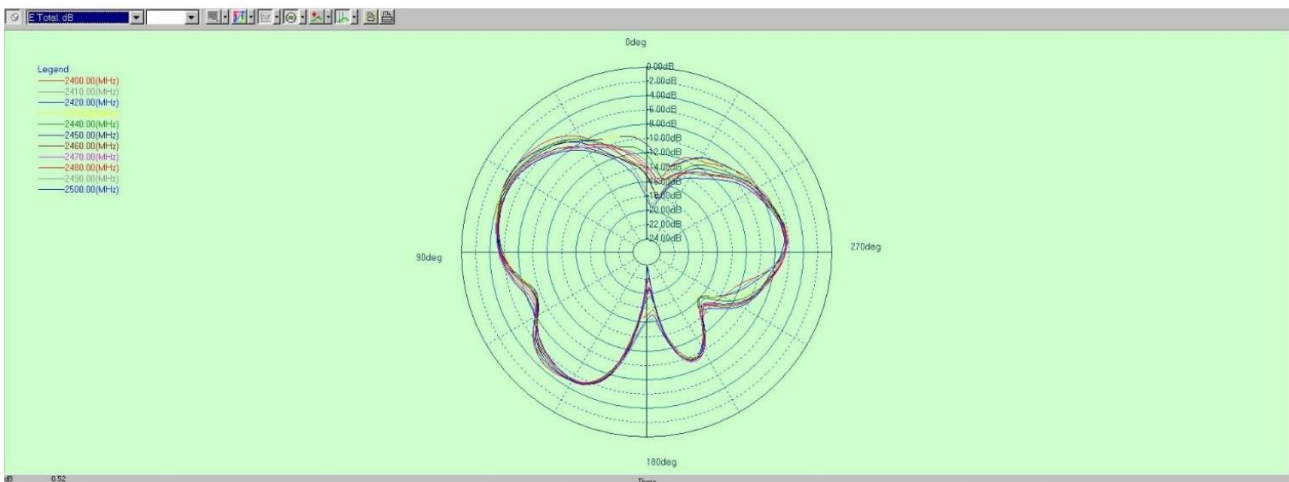


B.2 1D Radiation Pattern

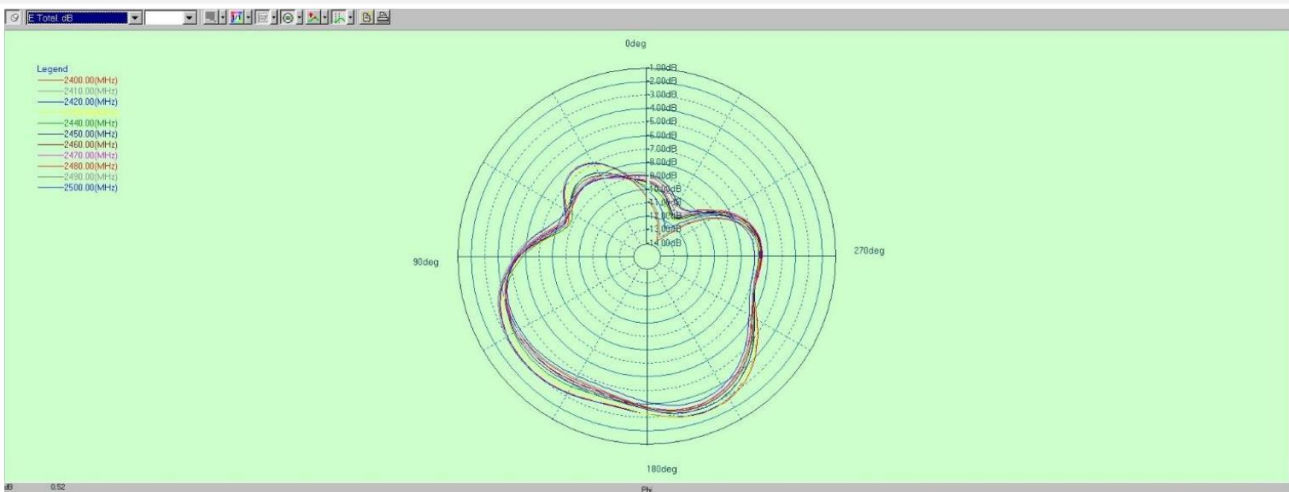
B2.1 PHI=0



B2.2 PHI=90



B2.3 THETA=90



Statement

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--END OF REPORT--